

IN THE UNITED STATES DISTRICT COURT
FOR THE NORTHERN DISTRICT OF CALIFORNIA

SYNAPTICS INCORPORATED,

No. C 07-06434 CRB

Plaintiff,

**ORDER RE CLAIM CONSTRUCTION
HEARING**

v.

ELANTECH DEVICES CORPORATION,

Defendant.

The claim construction hearing in the above matter is scheduled for Tuesday, October 21, 2008 at 10:00 a.m. At oral argument the parties should focus their presentations on the following questions:

A. Capacitance profile

1. What, if anything, is wrong with the following constructions?

“Capacitance profile” means “a set of data representing processed and quantified capacitance information;” or

“Capacitance profile” means “a collection of processed and quantified capacitance information.”

2. Does “a complete set of capacitance measurements [in a given direction]” include capacitance measurements for all conductive lines [in a given direction]?

3. How does “a complete set of capacitance measurements [in a given direction]” differ from “a complete set of sampled points [in a given direction]?”

1 4. Can a “capacitance profile” be developed using less than “a complete set of
2 capacitance measurements.”

3 5. Can a “capacitance profile” be developed using less than “a complete set of
4 sampled points?”

5 **B. “Developing capacitance profiles”**

6 1. What, if anything, is wrong with the following construction?

7 “Developing capacitance profiles” means “simultaneously measuring the capacitance
8 on [a set of] conductive lines in an X or Y direction and then processing that
9 capacitance information.”

10 2. Does the parallel scanning technique require that all conductive lines be
11 measured simultaneously? Or could fewer than all conductive lines (such as a plurality or a
12 subset of conductive lines) be measured simultaneously?

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14 Each party is allotted up to 30 minutes for argument.

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16 **IT IS SO ORDERED.**

17 Dated: October 17, 2008



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19 CHARLES R. BREYER
20 UNITED STATES DISTRICT JUDGE
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